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(54)	TIME-OF	F-FLIGHT MASS SPECTROMETER		
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		250/287; 250/396 R		
(58)	Field of S	earch 250/287, 396 R;		
		315/500, 501, 502, 503, 504, 505		
(56)		References Cited		
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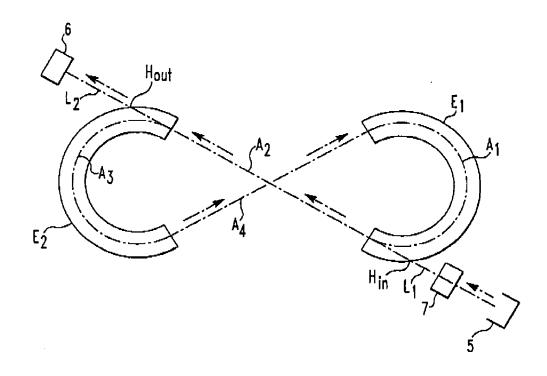
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Primary Examiner-Bruce C. Anderson

(57) ABSTRACT

A small-sized, high-resolution, time-of-flight (TOF) mass spectrometer has a closed ion orbit formed by plural electric sectors. Ions can make plural revolutions in the closed orbit. An entrance path is formed in the closed orbit to introduce ions into the closed orbit. An exit path is formed in the closed orbit to take ions from the closed orbit. The entrance and exit paths can be formed at the exit and entrance of the electric sectors forming the closed orbit or can be positioned in the orbit between the electric sectors forming the closed orbit.

8 Claims, 3 Drawing Sheets

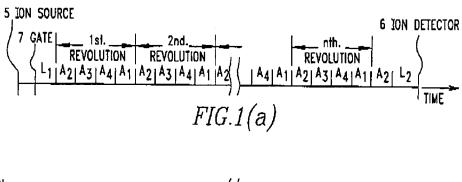


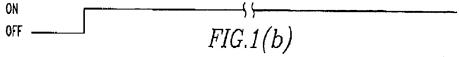
U.S. Patent

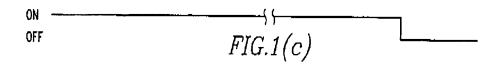
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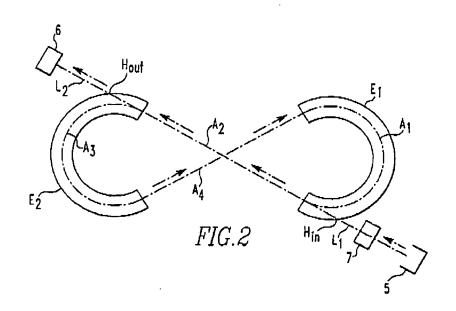
Sheet 1 of 3

US 6,300,625 B1







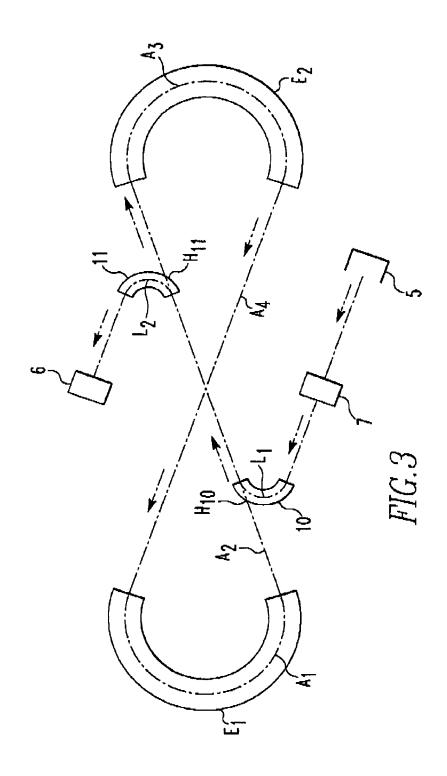


U.S. Patent

Oct. 9, 2001

Sheet 2 of 3

US 6,300,625 B1

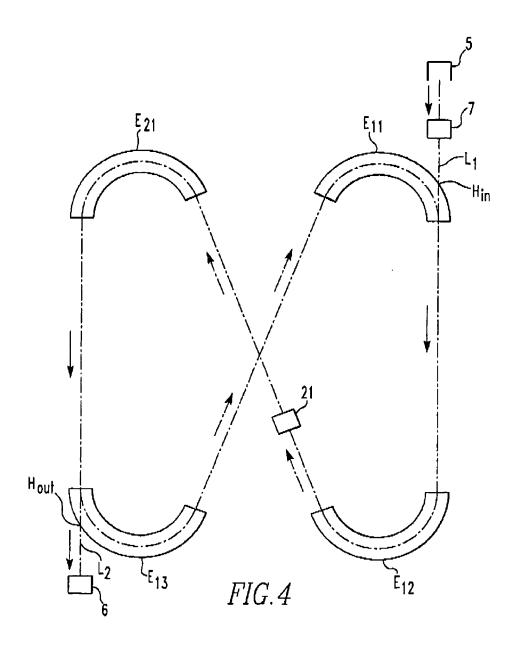


U.S. Patent

Oct. 9, 2001

Sheet 3 of 3

US 6,300,625 B1



US 6,300,625 B1

1

TIME-OF-FLIGHT MASS SPECTROMETER

FIELD OF THE INVENTION

The present invention relates to a time-of-flight (TOF) mass spectrometer having a closed orbit formed by plural.

BACKGROUND OF THE INVENTION

When ions are accelerated by an electric field, ions having smaller masses are more easily accelerated, while ions having greater masses are less easily accelerated. A time-of-flight (TOF) mass spectrometer is an instrument for performing mass analysis by measuring the differences in flight time (i.e., the time taken for ions to reach the ion detector) by making use of the principle described above.

In a TOF mass spectrometer, as the ion flight distance increases, ion mass differences tend to produce greater flight time differences. Therefore, one method of improving the resolution of the instrument is to increase the flight distance.

One known method for achieving both increase of flight 20 distance and miniaturization of the instrument is to cause the direction of flight of lons to make a U-turn, using electric fields, for example.

SUMMARY OF THE INVENTION

In view of the foregoing, it is an object of the present invention to provide a time-of-flight (TOF) mass spectrometer having a closed orbit formed by plural. The flight distance is increased by knocking ions into and out of the closed orbit. At the same time, the instrument is made ³⁰ smaller.

This object is achieved by a TOF mass spectrometer comprising a closed orbit formed by plural, an entrance path for knocking ions into the closed orbit and an exit path for taking the ions from the closed orbit.

in one feature of the invention, electrodes producing the forming the closed orbit are provided with holes to permit the ions to enter and leave the closed orbit.

In another feature of the invention, auxiliary electric fields 40 forming the entrance path and the exit path for the closed orbit are formed in a free flight space within the closed orbit.

In a further feature of the invention, the are switched off when the ions are knocked into and out of the closed orbit.

Other objects and features of the invention will appear in 45 the course of the description thereof, which follows.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1(a) is a diagram illustrating the paths that ions follow in a TOF mass spectrometer shown in FIG. 2, the spectrometer being built in accordance with the present invention;

FIGS. 1(b) and 1(c) are timing diagrams illustrating the timing at which electric fields within the TOF mass spectrometer shown in FIG. 2 are turned on and off;

FIG. 2 is a schematic diagram of a TOF mass spectrometer in accordance with the present invention;

FIG. 3 is a schematic diagram of another TOF mass spectrometer in accordance with the present invention; and a FIG. 4 is a schematic diagram of a further TOF mass

FIG. 4 is a schematic diagram of a further TOF mass spectrometer in accordance with the present invention.

DESCRIPTION OF THE PREFERRED EMBODIMENTS

A time-of-flight (TOF) wass spectrometer in accordance with the present invention is shown in FIG. 2. This spec-

2

trometer has a closed ion orbit formed by circular paths A_1 and A_3 and straight paths A_2 and A_4 . The circular paths A_1 and A_3 are within two electric sectors E_1 and E_2 , respectively, which make deflection angles of greater than 180° . The straight paths A_2 and A_4 cross each other and connect the two circular paths A_1 and A_2 . Ions are emitted as pulses from an ion source 5 and travel toward an ion detector 6. A gate 7 is mounted to pass only ions having a given range of velocities.

Ions going out of the gate 7 move straight in a path L_1 that is in agreement with the straight path A_2 . A pair of electrodes produces the electric sector E_1 . The outer one of these electrodes is provided with a hole H_{0a} near the exit of the electric field to prevent impediment to the movement of ions traveling in the path L_1 . Therefore, the ions going out of the gate 7 can pass between these electrodes through the hole H_{ia} and travel in the straight path A_2 .

An ion take-cut hole H_{out} is formed near the entrance of the electric sector \mathbb{P}_2 developed by a pair of electrodes to extract ions from the closed orbit. This ion takeout hole H_{out} is so located that ions traveling in the straight path A_2 would collide with the electrode forming the electric sector E_2 if they moved further straight. The ions going out of the electrodes through the ion takeout hole H_{out} pass through the path L_2 into the ion detector 6, where they are detected.

The operation of the instrument constructed in this way is next described by referring to FIGS. 1(a), 1(b) and 1(c). Pulsed ions eater the closed orbit and travel in this circular orbit. Then, the ions are taken from the closed orbit and reach the detector 6. FIG. 1(a) is a diagram illustrating these paths that the ions follow successively. FIG. 1(b) illustrates the timing at which the electric sector E_1 is turned on when the ions are admitted to the closed orbit. FIG. 1(c) illustrates the timing at which the electric sector E_2 is turned on when the ions are extracted from the closed orbit.

In FIG. 1(a), an assemblage of pulsed ions generated from the ion source 5 and passed through the gate 7 follows the path L_1 and enters the straight path A_2 . When these ions are passing between the electrides producing the electric sector B_1 , this electric field is turned off (zero potential), as shown in FIG. 1(b), to prevent the ions from being deflected due to the electric sector E_1 . After the ions of interest pass between the electrodes producing the electric sector B_1 , this electric field is turned on before the ions again reach the electric sector E_1 . Thus, an electric field of a given strength is produced. In this way, the ions are admitted to the closed orbit and travel in a figure-eight orbit formed by the paths A_2 , A_3 , A_4 , A_1 , A_2 , and so on.

After the ions introduced in the closed orbit make a required number, n, of revolutions in the figure-eight orbit, the electric sector E_2 is turned off (zero potential), as shown in FIG. 1(c), to take the ions out of the closed orbit. Obviously, the field E_2 is turned off while the ions do not stay in the electric sector E_2 . In particular, the ions are dispersed while traveling in the electric sector E_2 . The electric sector E_2 is turned off between the instant when the last ones of these dispersed ions leave the electric sector E_2 and the instant when the forefront ions enter the sector E_2 .

As a result, the ions making n revolutions in the closed orbit move straight without being deflected by the electric sector E₂. The ions are then taken out of the electrodes via the ion takeout bole H_{set} and admitted to the ion detector 6, where they are detected.

FIG. 3 shows another TOF mass spectrometer in accordance with the present invention. In this embodiment, an entrance path L₁ and an exit path L₂ are in a straight path A₂

connecting both electric sectors. An electric sector 10 for introducing ions and an electric sector 11 for extracting ions are added to bring the entrance path and the exit path into agreement with the straight path. The electric sectors 10 and 11 are turned on only during the introduction and departure of ions; the electric sectors 10 and 11 are kept off during the other interval. The electrodes forming the electric sectors 10 and 11 are provided with ion passage holes H₁₀ and H₁₁ to prevent impediment to the passage of the ions traveling in the closed orbit when the electric sectors are off.

Referring still to FIG. 3, the pulsed ions emitted from the ion source 5 pass through the gate 7 and enter the electric sector 10 forming the entrance path Li. At this time, the electric sector 10 is ON and produces an electric field of a given strength. Consequently, the ions are deflected by the electric sector 10 and admitted to the straight path Λ_2 . The 15 ions begin to travel in the figure-eight orbit formed by the circular paths A1, A3 and the straight paths A2, A4.

The electric sector 10 is turned off (zero potential) until the ions again approach the electric sector 10. The ions can pass through the hole H₁₀ formed in the electrode producing 20 the electric sector 10, and can keep revolving in the closed circular orbit.

When the ions introduced in the closed orbit finish the required number of revolutions, the electric sector 11 is turned on, thereby extracting the ions. Specifically, the 25 electric sector 11 is turned on, and an electric field of a given strength is developed. The ions reaching the electric sector 11 are deflected by the electric sector 11, move in the exit path L2, are extracted from the closed orbit, and reach the ion detector 6.

FIG. 4 shows a further TOF mass spectrometer in accordance with the present invention. In the spectrometer shown in FIG. 2, electric sectors E_1 and E_2 are produced. In the spectrometer shown in FIG. 4, these electric sectors E_1 and E_2 are divided into electric sectors E_{11} , E_{12} and E_{21} , E_{22} , respectively, having deflection angles of less than 180°. The closed orbit is formed by these four electric sectors. This increases the number of degrees of freedom in selecting electric sectors where the entrance path L, and the exit path L2 are positioned.

In the present embodiment, a gate 21 is mounted in a straight path to prevent faster ions from outninning slower ions. The gate 21 is not always essential to the present invention but useful in preventing this undesirable phenomenon while the ions are moving in the circular orbit; otherwise, the spectrum would be complicated.

In this way, the entrance and exit paths can be devised variously. A reflectron or any other device capable of constructing a TOF mass spectrometer may be included in the included in the closed orbit. Furthermore, any appropriate combination of them may be employed.

In the embodiments described above, the holes to pass the ions may be kept open if the electric fields are unaffected, However, if the electric fields are disturbed greatly, fine 55 mesh may be attached to the holes. This minimizes disturbance of the electric fields while permitting passage of ions.

While three embodiments of the invention have been described in detail thus far, the minimum requirements of the present invention are as follows.

(1) There exists a closed orbit formed by plural electric sectors. Furthermore, there exist entrance and exit paths permitting ions to enter and leave the closed orbit. The colrance and exit paths are partially coincident with the closed orbit. Alternatively, the entrance and exit paths 65 taken from said closed ion orbit. may be in contact with the closed orbit at least at one

- (2) Where the entrance and exit paths intersect or overlap the closed orbit, holes are formed in the electrodes at the intersections.
- (3) When ions are made to enter into or exit from the closed orbit, it is necessary at appropriate timing to turn off the electric sector that would otherwise impede the entry or exit of the ions.

A TOF mass spectrometer in accordance with the present invention has a closed orbit formed by plural electric sectors and a mechanism for forcing ions into and out of the closed orbit. Therefore, the number of revolutions that the ions make can be increased to thereby increase the flight distance, though the instrument is small. As a result, a small-sized, high-resolution TOF mass spectrometer can be accomplished.

Having thus described my invention with the detail and particularity required by the Patent Laws, what is desired protected by Letters Patent is set forth in the following claims

What is claimed is:

- 1. A time-of-flight mass spectrometer comprising:
- a) plural electric sectors defining a closed ion orbit formed;
- b) means for knocking ions into said closed ion orbit from an entrance path connected with said closed ion orbit;
- c) means for taking the ions from said closed ion orbit into an exit path connected with said closed ion orbit.
- 2. The time-of-flight mass spectrometer of claim 1, wherein said electric sectors are located opposite to each other and have deflection angles of greater than 180°.
- 3. The time-of-flight mass spectrometer of claim 1, wherein four electric sectors are spaced from each other and 35 have deflection angles of less than 180°.
 - 4. The time-of-flight mass spectrometer of claim 1, wherein electrodes producing said electric sectors forming the closed ion orbit are provided with holes to permit ions to enter and leave said closed ion orbit.
- 5. The time-of-flight mass spectrometer of claim 4, wherein said electric sectors include a first electric sector which has a hole permitting ions to be knacked into said closed ion orbit and which is turned off when the ions are knocked into said closed ion orbit, and wherein said electric 45 sectors include a second electric sector which has a hole permitting ions to be taken out of said closed ion orbit and which is turned off when the loas are taken out of said closed ion orbit.
- The time-of-flight mass spectrometer of claim 1, closed orbit. A quadrupole lcns or einzel lens may be 50 wherein said means for knocking ions into said closed orbit comprises a first auxiliary electric field for forming said entrance path on an ion path between said electric sectors and said means for taking ions from said closed orbit comprises a second auxiliary electric field for forming said exit path on an ion path between said electric sectors.

7. The time-of-flight mass spectrometer of claim 6, wherein electrodes for forming said auxiliary electric fields are provided with holes to permit passage of the ions rotating in said closed ion orbit.

8. The time-of-flight mass spectrometer of claim 6 or 7, wherein said first auxiliary electric field for forming said entrance path is turned on when ions are knocked into said closed ion orbit, and wherein said second auxiliary electric field for forming said exit path is turned on when the ions are

UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 6,300,625 B1 : October 9, 2001 DATED INVENTOR(S) : Morio Ishihara

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column L.

Line 5, "plural." should read -- plural sectors. --. Line 28, "plural." should read -- plural sectors. --. Line 33, "plural," should read -- plural sectors, --. Line 37, after "producing the" insert -- sectors --. Line 43, "the are" should read - the sectors are -.

Signed and Sealed this

Nineteenth Day of March, 2002

Arrest:

Auesting Officer

JAMES E. ROOAN

Director of the United States Paters and Trademark Office